



Designation: **D5568 – 08 D5568 – 14**

Standard Test Method for Measuring Relative Complex Permittivity and Relative Magnetic Permeability of Solid Materials at Microwave Frequencies Using Waveguide¹

This standard is issued under the fixed designation D5568; the number immediately following the designation indicates the year of original adoption or, in the case of revision, the year of last revision. A number in parentheses indicates the year of last reapproval. A superscript epsilon (ε) indicates an editorial change since the last revision or reapproval.

1. Scope*

1.1 This test method covers a procedure for determining relative complex permittivity (relative dielectric constant and loss) and relative magnetic permeability of isotropic, reciprocal (non-gyromagnetic) solid materials. If the material is nonmagnetic, it is acceptable to use this procedure to measure permittivity only.

1.2 This measurement method is valid over a frequency range of approximately 100 MHz to over 2040 GHz. These limits are not exact and depend on the size of the specimen, the size of rectangular waveguide transmission line used as a specimen holder, and on the applicable frequency range of the network analyzer used to make measurements. The practical lower and upper frequencies are limited by specimen dimension requirements (large specimens at low frequencies and small specimens at high frequencies); size of specimen dimension is limited by test frequency, intrinsic specimen electromagnetism properties, and the request of algorithm. Being a non-resonant method, the selection of any number of discrete measurement frequencies in a measurement band would be suitable. Use of multiple rectangular waveguide transmission line sizes are required to cover this entire frequency range (100 MHz to 2040 GHz). This test method can also be generally applied to circular waveguide test fixtures. The rectangular waveguide fixture is preferred over coaxial fixtures when samples have in-plane anisotropy or are difficult to manufacture precisely.

1.3 The values stated in SI units are to be regarded as the standard. The values given in parentheses are in English units; inch-pound units and are included for information only. The equations shown here assume an $e^{+j\omega t}$ harmonic time convention.

1.4 *This standard does not purport to address all of the safety concerns, if any, associated with its use. It is the responsibility of the user of this standard to establish appropriate safety and health practices and determine the applicability of regulatory limitations prior to use.*

2. Referenced Documents

2.1 ASTM Standards:²

D1711 Terminology Relating to Electrical Insulation

3. Terminology

3.1 For other definitions used in this test method, refer to Terminology **D1711**.

3.2 *Definitions:*

3.2.1 *relative complex permittivity (relative complex dielectric constant), ϵ_r^* , n* —the proportionality factor that relates the electric field to the electric flux density, and which depends on intrinsic material properties such as molecular polarizability, charge mobility, etc.; and so forth:

$$\epsilon_r^* = \epsilon_r' - j\epsilon_r'' = \frac{\vec{D}}{\epsilon_0 E} \quad (1)$$

¹ This test method is under the jurisdiction of ASTM Committee **D09** on Electrical and Electronic Insulating Materials and is the direct responsibility of Subcommittee **D09.12** on Electrical Tests.

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² For referenced ASTM standards, visit the ASTM website, www.astm.org, or contact ASTM Customer Service at service@astm.org. For *Annual Book of ASTM Standards* volume information, refer to the standard's Document Summary page on the ASTM website.

*A Summary of Changes section appears at the end of this standard

where:

ϵ_0 = the permittivity of free space,
 \vec{D} = the electric flux density vector, and
 \vec{E} = the electric field vector.

3.2.1.1 Discussion—

In common usage the word “relative” is frequently dropped. The real part of complex relative permittivity (ϵ_r') is often referred to as simply relative permittivity, permittivity, or dielectric constant. The imaginary part of complex relative permittivity (ϵ_r'') is often referred to as the loss factor. In anisotropic media, permittivity is described by a three dimensional tensor.

3.2.1.2 Discussion—

For the purposes of this test method, the media is considered to be isotropic, and therefore permittivity is a single complex number at each frequency.

3.2.2 *relative complex permeability, μ_r^* , n* —the proportionality factor that relates the magnetic flux density to the magnetic field, and which depends on intrinsic material properties such as magnetic moment, domain magnetization, etc., and so forth:

$$\mu_r^* = \mu_r' - j\mu_r'' = \frac{\vec{B}}{\mu_0 \vec{H}} \quad (2)$$

where:

μ_0 = the permeability of free space,
 \vec{B} = the magnetic flux density vector, and
 \vec{H} = the magnetic field vector.

3.2.2.1 Discussion—

In common usage the word “relative” is frequently dropped. The real part of complex relative permeability (μ_r') is often referred to as relative permeability or simply permeability. The imaginary part of complex relative permeability (μ_r'') is often referred to as the magnetic loss factor. In anisotropic media, permeability is described by a three dimensional tensor.

3.2.2.2 Discussion—

For the purposes of this test method, the media is considered to be isotropic, and therefore permeability is a single complex number at each frequency.

3.3 Definitions of Terms Specific to This Standard:

3.3.1 A list of symbols specific to this test method is given in **Annex A1**.

3.3.2 *calibration, n* —a procedure for connecting characterized standard devices to the test ports of a network analyzer to characterize the measurement system’s systematic errors. The effects of the systematic errors are then mathematically removed from the indicated measurements. The calibration also establishes the mathematical reference plane for the measurement test ports.

3.3.2.1 Discussion—

Modern network analyzers have this capability built in. There are a variety of calibration kits that can be used depending on the type of test port. The models used to predict the measurement response of the calibration devices depends on the type of calibration kit. Most calibration kits come with media that can be used to load the definitions of the calibration devices into the network analyzer. Calibration kit definitions loaded into the network analyzer must match the devices used to calibrate. Since both transmission and reflection measurements are used in this standard, a two-port calibration is required.

3.3.3 *network analyzer, n* —a system that measures the two-port transmission and one-port reflection characteristics of a multiport system in its linear range and at a common input and output frequency.

3.3.3.1 Discussion—